

Complementary MOSFET

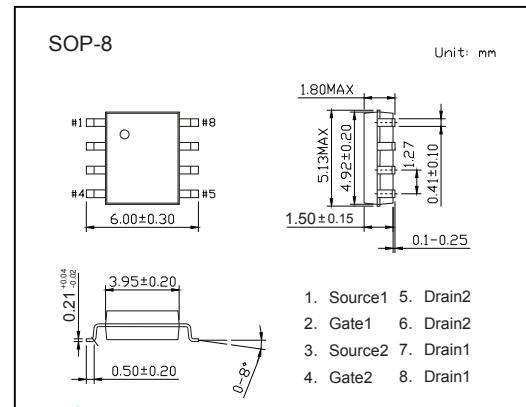
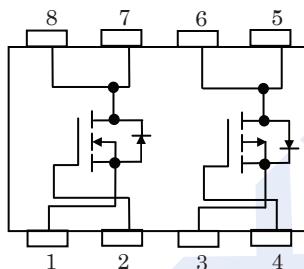
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■ Features

● N-Channel

 $V_{DS} = 30V, I_D = 5A$ $R_{DS(ON)} = 24m\Omega @ V_{GS}=10V$ $R_{DS(ON)} = 35m\Omega @ V_{GS}=4.5V$

● P-Channel

 $V_{DS} = -30V, I_D = -5A$ $R_{DS(ON)} = 50m\Omega @ V_{GS}=-10V$ $R_{DS(ON)} = 75m\Omega @ V_{GS}=-4.5V$ ■ Absolute Maximum Ratings ($T_A = 25^\circ C$ Unless otherwise specified)

Parameter	Symbol	N-CH	P-CH	Unit
Drain-Source Voltage	V_{DS}	30	-30	V
Gate-Source Voltage	V_{GS}	± 20	± 20	
Continuous Drain Current (Note 1a)	I_D	5	-5	A
Pulsed Drain Current	I_{DM}	20	-20	
Power Dissipation for Dual Operation	P_D	2		W
Power Dissipation for Single Operation (Note 1a)		1.6		
(Note 1b)		1		
(Note 1c)		0.9		
Thermal Resistance, Junction- to-Ambient (Note 1a)	$R_{\theta JA}$	78		°C/W
Thermal Resistance, Junction- to-Case (Note 1)	$R_{\theta JC}$	40		
Junction Temperature	T_J	150		
Storage Temperature Range	T_{stg}	-55 to 150		°C

Notes:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.
 - 78°C/W when mounted on a 0.5 in² pad of 2 oz copper
 - 125°C/W when mounted on a 0.02 in² pad of 2 oz copper
 - 135°C/W when mounted on a minimum pad.

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■ Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless otherwise specified)

Parameter	Symbol	Test Conditions	Type	Min	Typ	Max	Unit	
Off Characteristics								
Drain-Source Breakdown Voltage	V _{DSS}	I _D =250μA, V _{GS} =0V	N-CH	30			V	
		I _D =-250μA, V _{GS} =0V	P-CH	-30				
Zero Gate Voltage Drain Current	I _{DSS}	V _D =24V, V _{GS} =0V	N-CH			1	μA	
		V _D =-24V, V _{GS} =0V	P-CH			-1		
Gate-Body Leakage Current	I _{GSS}	V _D =0V, V _{GS} =±20V	N-CH			±100	nA	
		V _D =0V, V _{GS} =±20V	P-CH			±100		
On Characteristics (Note 2)								
Gate Threshold Voltage	V _{GS(th)}	V _D =V _{GS} , I _D =250μA	N-CH	1		3	V	
		V _D =V _{GS} , I _D =-250μA	P-CH	-1		-3		
Static Drain-Source On-Resistance	R _{D(on)}	V _{GS} =10V, I _D =5A	N-CH		24	30	mΩ	
		V _{GS} =10V, I _D =5A, T _J =125°C			32	42		
		V _{GS} =4.5V, I _D =4A			35	40		
		V _{GS} =-10V, I _D =-5A	P-CH		50	54		
		V _{GS} =-10V, I _D =-5A, T _J =125°C			58	78		
		V _{GS} =-4.5V, I _D =-4A			75	80		
Forward Transconductance	g _F	V _D =5V, I _D =5A	N-CH		19		S	
		V _D =-5V, I _D =-5A	P-CH		11			
Dynamic Characteristics (Note 2, 3)								
Input Capacitance	C _{iss}	N-Channel: V _{GS} =0V, V _D =10V, f=1MHz P-Channel: V _{GS} =0V, V _D =-10V, f=1MHz	N-CH		789		pF	
			P-CH		690			
Output Capacitance	C _{oss}		N-CH		173			
			P-CH		306			
Reverse Transfer Capacitance	C _{rss}		N-CH		66			
			P-CH		77			
Switching Characteristics (Note 2, 3)								
Total Gate Charge	Q _g	N-Channel: V _{GS} =10V, V _D =15V, I _D =7A P-Channel: V _{GS} =-10V, V _D =-15V, I _D =-5A	N-CH		16	26	nC	
			P-CH		14	23		
Gate Source Charge	Q _{gs}		N-CH		2.5			
			P-CH		2.4			
Gate Drain Charge	Q _{gd}		N-CH		2.6			
			P-CH		4.8			
Turn-On Delay Time	t _{d(on)}	N-Channel: V _{DD} =10V, I _D =1A, V _{GS} =10V, R _{GEN} =6Ω P-Channel: V _{DD} =-10V, I _D =-1A, V _{GS} =-10V, R _{GEN} =6Ω	N-CH		2.2		ns	
			P-CH		6.7			
Turn-On Rise Time	t _r		N-CH		7.5			
			P-CH		9.7			
Turn-Off Delay Time	t _{d(off)}		N-CH		11.8			
			P-CH		19.8			
Turn-Off Fall Time	t _f		N-CH		3.7			
			P-CH		12.3			
Drain-Source Diode Characteristics								
Diode Forward Voltage	V _{SD}	I _S =1.3A, V _{GS} =0V	N-CH			1.2	V	
		I _S =-1.3A, V _{GS} =0V	P-CH			-1.2		

Notes 2. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.

3. Guaranteed by design, not subject to production

■ Marking

Marking	NP07 KC***
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■ Typical Characteristics (N-CH)

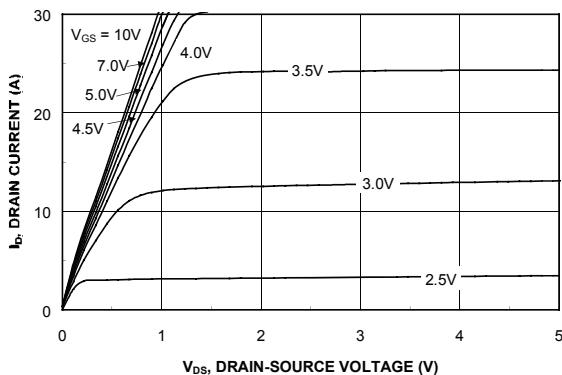


Figure 1. On-Region Characteristics.

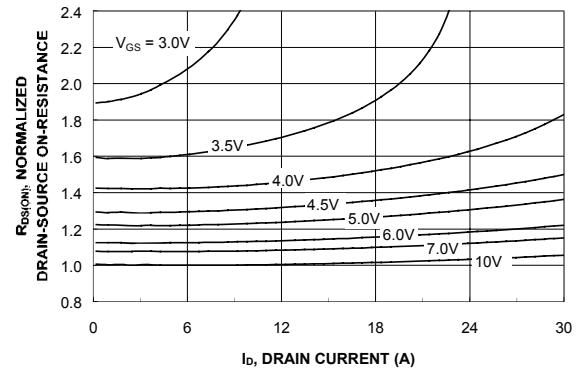


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

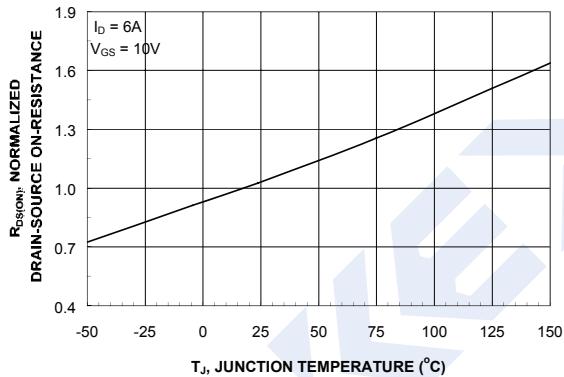


Figure 3. On-Resistance Variation with Temperature.

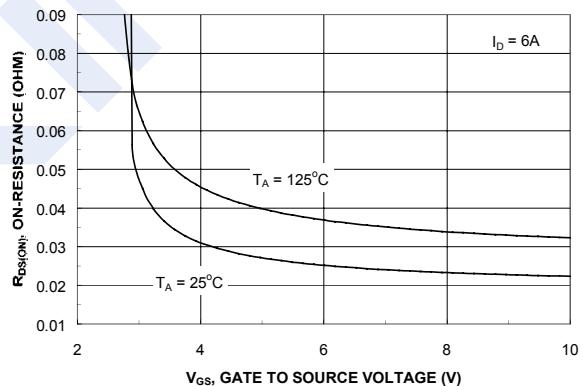


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

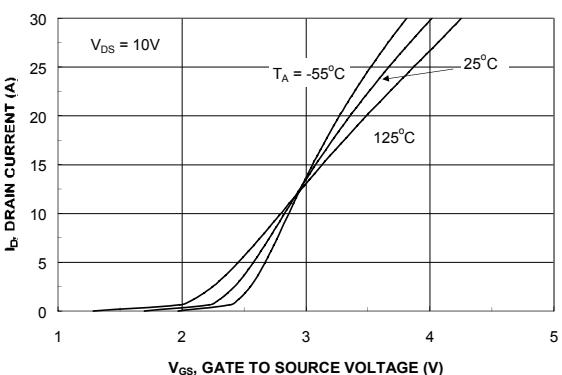


Figure 5. Transfer Characteristics.

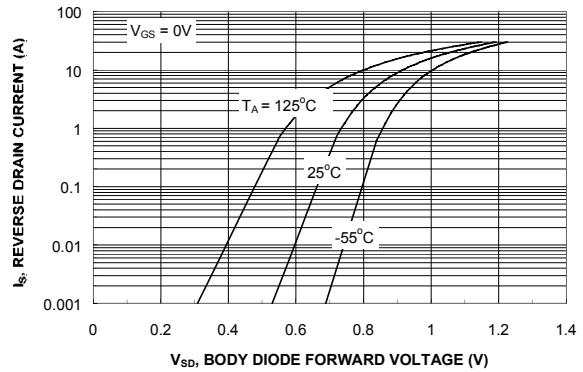


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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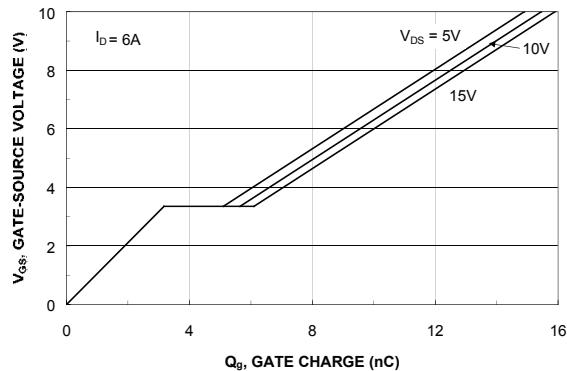


Figure 7. Gate Charge Characteristics.

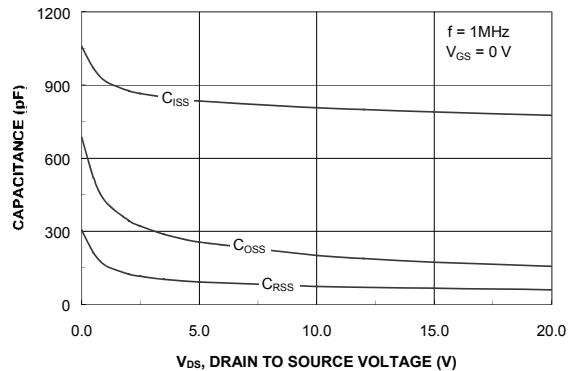


Figure 8. Capacitance Characteristics.

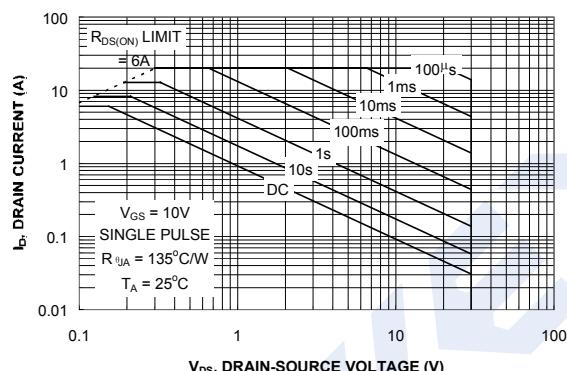


Figure 9. Maximum Safe Operating Area.

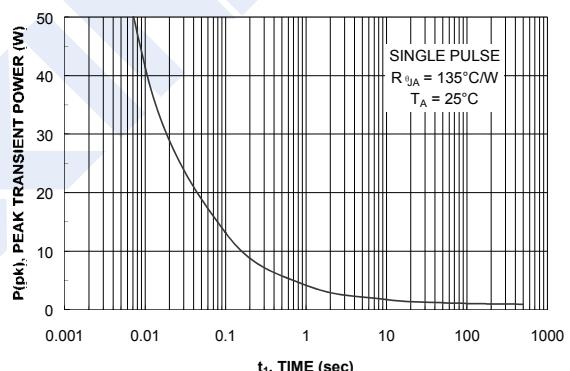


Figure 10. Single Pulse Maximum Power Dissipation.

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■ Typical Characteristics (P-CH)

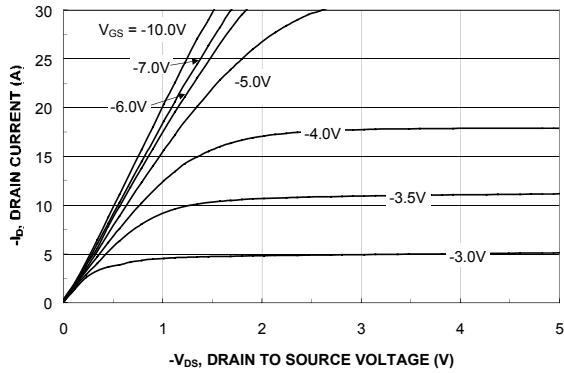


Figure 11. On-Region Characteristics.

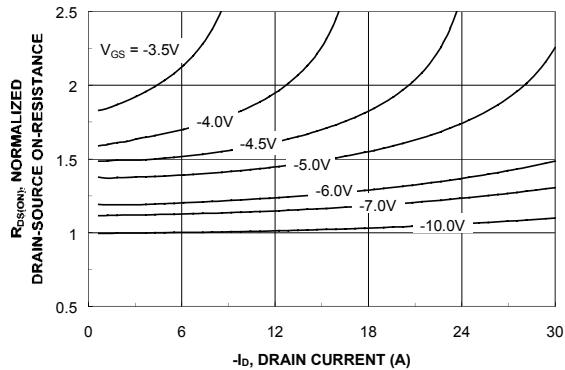


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

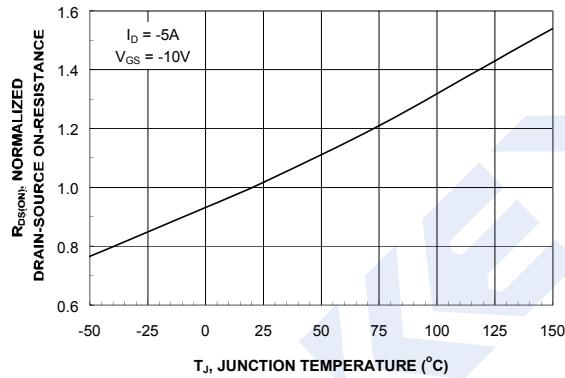


Figure 13. On-Resistance Variation with Temperature.

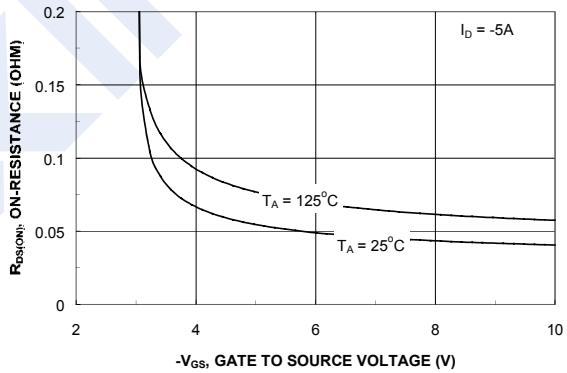


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

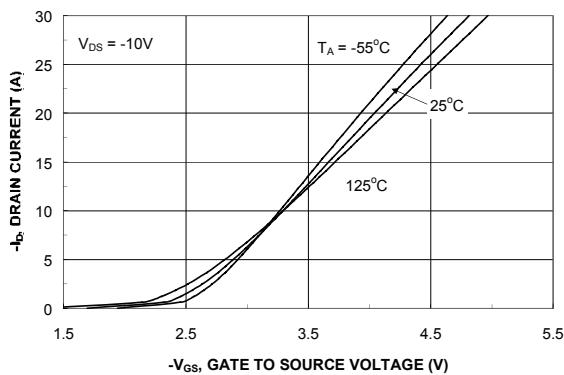


Figure 15. Transfer Characteristics.

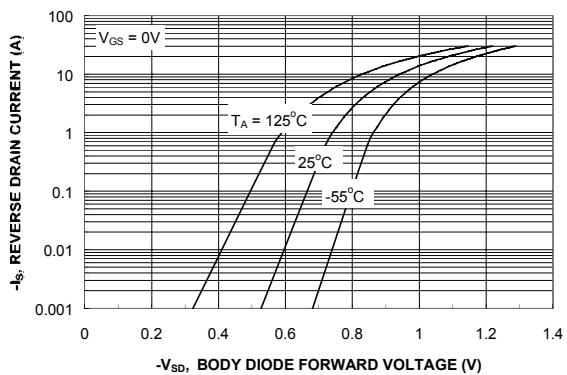


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

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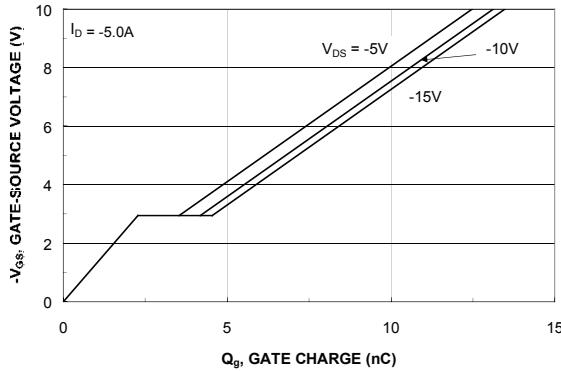


Figure 17. Gate Charge Characteristics.

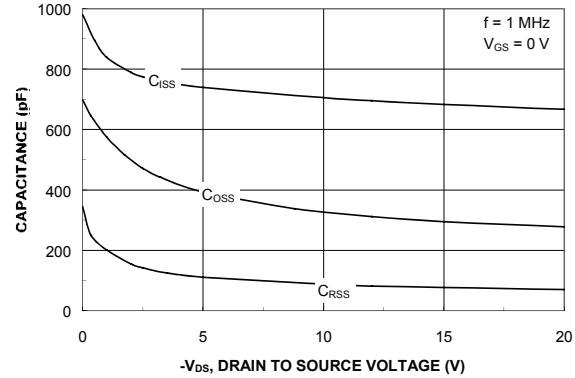


Figure 18. Capacitance Characteristics.

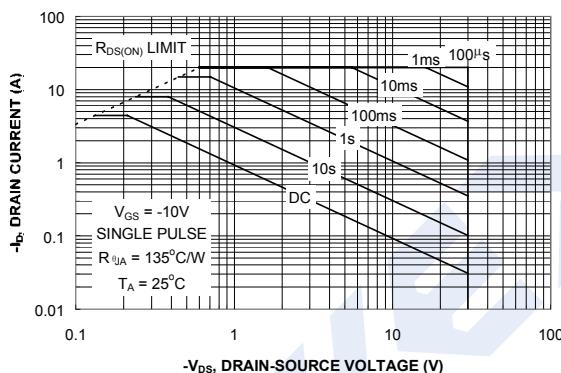


Figure 19. Maximum Safe Operating Area.

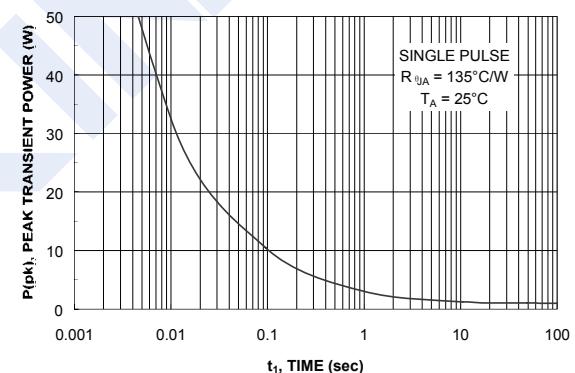


Figure 20. Single Pulse Maximum Power Dissipation.

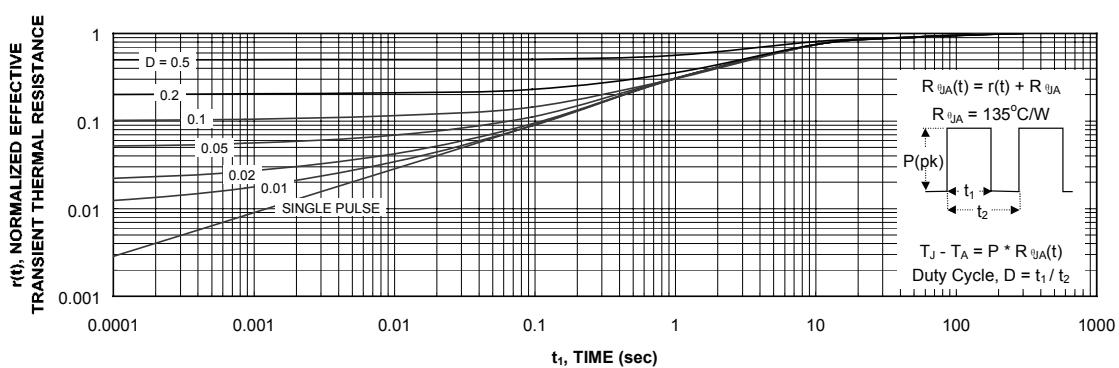


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.